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Application/Control No.	Applicant(s)/Patent under Reexamination	-
10/763,889	CHEN ET AL.	
Examiner	Art Unit	
Tuan V Thai	2186	

	SEAR	CHED	
Class	Subclass	Date	Examiner
711	100	6/8/2006	ТН
711	141	6/8/2006	тн
711	142	6/8/2006	тн
711	143	6/8/2006	тн
711	144	6/8/2006	тн
711	145	6/8/2006	ТН
711	146	6/8/2006	ТН
711	154	6/8/2006	тн

INTERFERENCE SEARCHED			
Class	Subclass	Date	Examiner
711	154	6/8/2006	ТН
711	141	6/8/2006	тн

SEARCH N (INCLUDING SEAR)		')
	DATE	EXMR
EAST updated searches: IBMTDB USPGPUB EPO/JPO abstr USPGPUB NORTH database NPL search IEEE database	6/8/2006	тн
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